10/537360

JC20 Rec'd PCT/PTO

Docket No.: 4590-416

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Thomas KLEY et al.

U.S. Patent Application No. not yet assigned

Filed: herewith

TUNABLE HIGH-FREQUENCY FILTER ARRANGEMENT AND METHOD FOR THE For:

PRODUCTION THEREOF

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Please note this is a PCT application in the entry of the National Phase in the U.S. and copies of the references cited were transmitted by WIPO and are believed to be in the file of the above-identified application and readily available to the Examiner. Therefore it is believed that Applicants have met all requirements regarding duty of disclosure under 37 CFR 1.56. A copy of the foreign search report is attached for the Examiner's information. Acknowledgement and consideration of these documents are respectfully requested.

Respectfully submitted,

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Date: June 6, 2005

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Sheet 1 of 1

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1141.0	CITATION	N IN AN	APPLICANT Thomas KLE	APPLICANT Thomas KLEY et al.				
APPLICATION			FILING DATE herewith			GROUP		
	(PTO-1		DOCUMENTS		· · · · · · · · · · · · · · · · · · ·			
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EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	DA		
	5,612, 655 A	1997-03-18 S	tronks John et al					
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		FOREIGN PAT	ENT DOCUMENTS.			. Si d		
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Trans Yes	lation No	
	61 136302A	1986-11-12	JP					
	62 271503 A	1988-05-13	JP					
	0 601 369A	1994-06-15	EP					
	OTHE	R ART (Including Author	r, Title, Date, Pertine	nt Pages, Et	c)			
	IEEE TRANSAC	AL: "DIELECTRIC RIN TIONS ON MICROWA' 9, no.12 December 1, 199	E THEORY AND T	OR FOR AP ECHNIQUE	PLICATION I ES, IEEE INC.	N MM NEW	IC's	
	10KK, US VOI. 3	7, 110.112 December 1, 177	r huges moot mood			-		

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

**EXAMINER** 

DATE CONSIDERED